

Notice of References Cited

Application/Control No.

10/594,736

Applicant(s)/Patent Under
Reexamination
OKA ET AL.

Examiner

DAVID LUKTON

Art Unit

1654

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,074,832	06-2000	Venta et al.	435/6
*	B	US-6,015,689	01-2000	Okado et al.	435/69.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Abstract of Minoru (JP 07-101834, issued April, 1995)
*	V	Abstract of Yoshikawa (WO 00/29425; issued May, 2000)
*	W	Abstract of Kenji (JP 10-279501, issued October, 1998)
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.